# Testing for high-dimensional white noise using maximum cross correlations

## JINYUAN CHANG

School of Statistics, Southwestern University of Finance and Economics, Chengdu Sichuan 611130, China (jinyuan.chang@unimelb.edu.au)

#### QIWEI YAO

Department of Statistics, London School of Economics and Political Science WC2A 2AE, UK (q.yao@lse.ac.uk)

WEN ZHOU Department of Statistics, Colorado State University, Fort Collins Colorado 80523, USA (riczw@stat.colostate.edu)

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#### Abstract

We propose a new omnibus test for vector white noise using the maximum absolute autocorrelations and cross-correlations of the component series. Based on an approximation by the  $L_{\infty}$ -norm of a normal random vector, the critical value of the test can be evaluated by bootstrapping from a multivariate normal distribution. In contrast to the conventional white noise test, the new method is proved to be valid for testing the departure from white noise that is not independent and identically distributed. We illustrate the accuracy and the power of the proposed test by simulation, which also shows that the new test outperforms several commonly used methods including, for example, the Lagrange multiplier test and the multivariate Box–Pierce portmanteau tests, especially when the dimension of time series is high in relation to the sample size. The numerical results also indicate that the performance of the new test can be further enhanced when it is applied to pre-transformed data obtained via the time series principal component analysis proposed by Chang, Guo and Yao (arXiv:1410.2323). The proposed procedures have been implemented in an R package.

*Keywords*: Autocorrelation; Normal approximation; Parametric bootstrap; Portmanteau test; Time series principal component analysis; Vector white noise.

# **1** Introduction

Testing for white noise or serial correlation is a fundamental problem in statistical inference, as many testing problems in linear modelling can be transformed into a white noise test. Testing for white noise is often pursued in two different manners: (i) the departure from white noise is specified as an alternative hypothesis in the form of an explicit parametric family such as an autoregressive moving average model, and (ii) the alternative hypothesis is unspecified. With an explicitly specified alternative, a likelihood ratio test can be applied. Likelihood-based tests typically have more power to detect a specific form of the departure than omnibus tests which try to detect arbitrary departure from white noise. The likelihood approach has been taken further in

the nonparametric context using the generalized likelihood ratio test initiated by Fan et al. (2001); see Section 7.4.2 of Fan & Yao (2003) and also Fan & Zhang (2004). Nevertheless many applications including model diagnosis do not lead to a natural alternative model. Therefore various omnibus tests, especially the celebrated Box–Pierce test and its variants, remain popular. Those portmanteau tests are proved to be asymptotically  $\chi^2$ -distributed under the null hypothesis, which makes their application extremely easy. See Section 3.1 of Li (2004) and Section 4.4 of Lütkepohl (2005) for further information on those portmanteau tests.

While portmanteau tests are designed for testing white noise, their asymptotic  $\chi^2$ -distributions are established under the assumption that observations under the null hypothesis are independent and identically distributed. However, empirical evidence, including that in Section 4 below, suggests that this may represent another case in which the theory is more restrictive than the method itself. Asymptotic theory of portmanteau tests for white noise that is not independent and identically distributed has attracted a lot of attention. One of the most popular approaches is to establish the asymptotic normality of a normalized portmanteau test statistic. An incomplete list in this endeavour includes Durlauf (1991), Romano & Thombs (1996), Deo (2000), Lobato (2001), Francq et al. (2005), Escanciano & Lobato (2009) and Shao (2011). However, the convergence is typically slow. Horowitz et al. (2006) proposed a double blockwise bootstrap method to test for white noise that is not independent and identically distributed.

In this paper we propose a new omnibus test for vector white noise. Instead of using a portmanteautype statistic, the new test is based on the maximum absolute auto- and cross-correlation of all component time series. This avoids the impact of small correlations. When most auto- and cross-correlations are small, the Box-Pierce tests have too many degrees of freedom in their asymptotic distributions. In contrast the new test performs well when there is at least one large absolute auto- or cross-correlation at a non-zero lag. The null distribution of the maximum correlation test statistic can be approximated asymptotically by that of  $|G|_{\infty}$ , where G is a Gaussian random vector, and  $|u|_{\infty} = \max_{1 \le i \le s} |u_i|$  denotes the  $L_{\infty}$ -norm of a vector  $u = (u_1, \ldots, u_s)^{\mathrm{T}}$ . Its critical values can therefore be evaluated by bootstrapping from a multivariate normal distribution.

An added advantage of the new test is its ability to handle high-dimensional series, in the sense that the number of series is as large as, or even larger than, their length. Nowadays, it is common to model and forecast many time series at once, which has direct applications in, among others, finance, economics, environmental and medical studies. The current literature on high-dimensional time series focuses on estimation and dimension-reduction aspects. See, for example, Basu & Michailidis (2015), and Guo et al. (2016) and the references within for high-dimensional vector autoregressive models, and Bai & Ng (2002), Forni et al. (2005), Lam & Yao (2012) and Chang et al. (2015) for high-dimensional time series factor models. The model diagnostics has largely been untouched, as far as we are aware. The test proposed in this paper represents an effort to fill in this gap.

We compare the performance of the new test with those of the three Box–Pierce types of portmanteau tests, the Lagrange multiplier test and a likelihood ratio test in simulation, which shows that the new test attains the nominal significance levels more accurately and is also more powerful when the dimension of time series is large or moderately large. Its performance can be further enhanced by first applying time series principal component analysis, proposed by Chang, Guo and Yao (arXiv:1410.2323).

Let  $\otimes$  and vec denote, respectively, the Kronecker product and the vectorization for matrices,  $I_s$  be the  $s \times s$  identity matrix, and  $|A|_{\infty} = \max_{1 \le i \le \ell, 1 \le j \le m} |a_{ij}|$  for an  $\ell \times m$  matrix  $A \equiv (a_{i,j})$ . Denote by  $\lceil x \rceil$  and  $\lfloor x \rfloor$ , respectively, the smallest integer not less than x and the largest integer not greater than x.

## 2 Methodology

#### 2.1 Tests

Let  $\{\varepsilon_t\}$  be a *p*-dimensional weakly stationary time series with mean zero. Denote by  $\Sigma(k) = \operatorname{cov}(\varepsilon_{t+k}, \varepsilon_t)$ and  $\Gamma(k) = \operatorname{diag}\{\Sigma(0)\}^{-1/2}\Sigma(k)\operatorname{diag}\{\Sigma(0)\}^{-1/2}$ , respectively, the autocovariance and the autocorrelation of  $\varepsilon_t$  at lag k, where  $\operatorname{diag}(\Sigma)$  denotes the diagonal matrix consisting of the diagonal elements of  $\Sigma$  only. When  $\Sigma(k) \equiv 0$  for all  $k \neq 0$ ,  $\{\varepsilon_t\}$  is white noise.

With the available observations  $\varepsilon_1, \ldots, \varepsilon_n$ , let

$$\widehat{\Gamma}(k) \equiv \{\widehat{\rho}_{ij}(k)\}_{1 \le i,j \le p} = \operatorname{diag}\{\widehat{\Sigma}(0)\}^{-1/2}\widehat{\Sigma}(k)\operatorname{diag}\{\widehat{\Sigma}(0)\}^{-1/2}$$
(1)

be the sample autocorrelation matrix at lag k, where

$$\widehat{\Sigma}(k) = \frac{1}{n} \sum_{t=1}^{n-k} \varepsilon_{t+k} \varepsilon_t^{\mathrm{T}}$$
(2)

is the sample autocovariance matrix.

 $\xi_n$ 

Consider the hypothesis testing problem

 $H_0: \{\varepsilon_t\}$  is white noise versus  $H_1: \{\varepsilon_t\}$  is not white noise. (3)

Since  $\Gamma(k) \equiv 0$  for any  $k \geq 1$  under  $H_0$ , our test statistic  $T_n$  is defined as

$$T_n = \max_{1 \le k \le K} T_{n,k},\tag{4}$$

where  $T_{n,k} = \max_{1 \le i,j \le p} n^{1/2} |\hat{\rho}_{ij}(k)|$  and  $K \ge 1$  is a prescribed integer. We reject  $H_0$  if  $T_n > cv_{\alpha}$ , where  $cv_{\alpha} > 0$  is the critical value determined by

$$\operatorname{pr}(T_n > \operatorname{cv}_\alpha) = \alpha \tag{5}$$

under  $H_0$ , and  $\alpha \in (0, 1)$  is the significance level of the test.

To determine  $cv_{\alpha}$ , we need to derive the distribution of  $T_n$  under  $H_0$ . Proposition 1 below shows that the Kolmogorov distance between this distribution and that of the  $L_{\infty}$ -norm of a  $N(0, \Xi_n)$  random vector converges to zero, even when p diverges at an exponential rate of n, where

$$\Xi_n = (I_K \otimes W) E(\xi_n \xi_n^{\mathrm{T}}) (I_K \otimes W),$$

$$= n^{1/2} (\operatorname{vec}\{\widehat{\Sigma}(1)\}^{\mathrm{T}}, \dots, \operatorname{vec}\{\widehat{\Sigma}(K)\}^{\mathrm{T}})^{\mathrm{T}}, \quad W = \operatorname{diag}\{\Sigma(0)\}^{-1/2} \otimes \operatorname{diag}\{\Sigma(0)\}^{-1/2}.$$
(6)

This paves the way to evaluate  $cv_{\alpha}$  simply by drawing a bootstrap sample from  $N(0, \widehat{\Xi}_n)$ , where  $\widehat{\Xi}_n$  is an appropriate estimator for  $\Xi_n$ .

**Proposition 1.** Let Conditions 1–4 in Section 3 below hold and  $G \sim N(0, \Xi_n)$ . There exists a positive constant  $\delta_1$  depending only on the constants appeared in Conditions 1–4 for which  $\log p \leq Cn^{\delta_1}$  for some constant C > 0. Then it holds under  $H_0$  that

$$\sup_{s \ge 0} \left| \operatorname{pr}(T_n > s) - \operatorname{pr}(|G|_{\infty} > s) \right| \to 0, \quad \text{as } n \to \infty.$$

By replacing  $\Xi_n$  in (6) by  $\widehat{\Xi}_n$ , where  $\widehat{\Xi}_n$  is defined in Section 2.2 below, the critical value  $cv_\alpha$  in (5) can be replaced by  $\widehat{cv}_\alpha$  which is determined by

$$\operatorname{pr}(|G|_{\infty} > \widehat{\operatorname{cv}}_{\alpha}) = \alpha,\tag{7}$$

where  $G \sim N(0, \widehat{\Xi}_n)$ . In practice, we can draw  $G_1, \ldots, G_B$  independently from  $N(0, \widehat{\Xi}_n)$  for a large integer B. The  $\lfloor B\alpha \rfloor$ -th largest value among  $|G_1|_{\infty}, \ldots, |G_B|_{\infty}$  is taken as the critical value  $\widehat{cv}_{\alpha}$ . We then reject  $H_0$  whenever  $T_n > \widehat{cv}_{\alpha}$ .

**Remark 1.** When p is large or moderately large, it is advantageous to apply the time series principal component analysis proposed in arXiv:1410.2323 to the data first. We denote by  $T_n^*$  the resulted test. More precisely, we compute an invertible transformation matrix Q using the R function segmentTS in the package PCR4TS available at CRAN. Then  $T_n^*$  is defined in the same manner as  $T_n$  in (4) with  $\{\varepsilon_1, \ldots, \varepsilon_n\}$ replaced by  $\{\varepsilon_1^*, \ldots, \varepsilon_n^*\}$ , where  $\varepsilon_t^* = Q\varepsilon_t$ . As Q does not depend on t,  $\{\varepsilon_t, t \ge 1\}$  is white noise if and only if  $\{\varepsilon_t^*, t \ge 1\}$  is white noise. The time series principal component analysis makes the component autocorrelations as large as possible by suppressing the cross-correlations among different components at all time lags. This makes the maximum correlation greater, and therefore the test more powerful. See also the simulation results in Section 4.

### **2.2** Estimation of $\Xi_n$

By Lemma 3.1 of Chernozhukov et al. (2013), the proposed test in Section 2.1 is valid if the estimator  $\widehat{\Xi}_n$  satisfies  $|\widehat{\Xi}_n - \Xi_n|_{\infty} = o_p(1)$ . We construct such an estimator now even when the dimension of time series is ultra-high, i.e.  $p \gg n$ . Let  $\tilde{n} = n - K$  and

$$f_t = \{ \operatorname{vec}(\varepsilon_{t+1}\varepsilon_t^{\mathrm{T}}), \dots, \operatorname{vec}(\varepsilon_{t+K}\varepsilon_t^{\mathrm{T}}) \}^{\mathrm{T}} \quad (t = 1, \dots, \tilde{n}).$$
(8)

The second factor  $E(\xi_n \xi_n^T)$  on the right-hand side of (6) is closely related to  $var(\tilde{n}^{-1/2} \sum_{t=1}^{\tilde{n}} f_t)$ , the longrun covariance of  $\{f_t\}_{t=1}^{\tilde{n}}$ . The long-run covariance plays an important role in the inference with dependent data. There exist various estimation methods for long-run covariances, including the kernel-type estimators (Andrews, 1991), and the estimators utilizing the moving block bootstraps (Lahiri, 2003). See also Den Haan & Levin (1997) and Kiefer et al. (2000). We adopt the kernel-type estimator for the long-run covariance of  $\{f_t\}_{t=1}^{\tilde{n}}$ 

$$\widehat{J}_n = \sum_{j=-\tilde{n}+1}^{\tilde{n}-1} \mathcal{K}\left(\frac{j}{b_n}\right) \widehat{H}(j),\tag{9}$$

where  $\hat{H}(j) = \tilde{n}^{-1} \sum_{t=j+1}^{\tilde{n}} f_t f_{t-j}^{\mathrm{T}}$  if  $j \ge 0$  and  $\hat{H}(j) = \tilde{n}^{-1} \sum_{t=-j+1}^{\tilde{n}} f_{t+j} f_t^{\mathrm{T}}$  otherwise,  $\mathcal{K}(\cdot)$  is a symmetric kernel function that is continuous at 0 with  $\mathcal{K}(0) = 1$ , and  $b_n$  is the bandwidth diverging with n. Among a variety of kernel functions that guarantee the positive definiteness of the long-run covariance estimators, Andrews (1991) derived an optimal kernel, i.e. the quadratic spectral kernel

$$\mathcal{K}_{QS}(x) = \frac{25}{12\pi^2 x^2} \left\{ \frac{\sin(6\pi x/5)}{6\pi x/5} - \cos(6\pi x/5) \right\}$$
(10)

by minimizing the asymptotic truncated mean square error of the estimator. For the numerical study in Section 4, we always use this kernel function with an explicitly specified bandwidth selection procedure. The theoretical results in Section 3 apply to general kernel functions. As now  $\hat{J}_n$  in (9) provides an estimator for  $E(\xi_n \xi_n^T), \Xi_n$  in (6) can be estimated by

$$\widehat{\Xi}_n = (I_K \otimes \widehat{W}) \widehat{J}_n (I_K \otimes \widehat{W}),$$

where  $\widehat{W} = \text{diag}\{\widehat{\Sigma}(0)\}^{-1/2} \otimes \text{diag}\{\widehat{\Sigma}(0)\}^{-1/2}$  for  $\widehat{\Sigma}(0)$  defined in (2). Simulation results show that the proposed test with this estimator performs very well.

#### 2.3 Computational issues

To draw a random vector  $G \sim N(0, \widehat{\Xi}_n)$ , the standard approach consists of three steps: (i) perform the Cholesky decomposition for the  $p^2K \times p^2K$  matrix  $\widehat{\Xi}_n = L^T L$ , (ii) generate  $p^2K$  independent N(0, 1) random variables  $z = (z_1, \ldots, z_{p^2K})^T$ , (iii) perform transformation  $G = L^T z$ . Computationally this is an  $(np^4K^2 + p^6K^3)$ -hard problem requiring a large storage space for  $\{f_t\}_{t=1}^{\tilde{n}}$  and matrix  $\widehat{\Xi}_n$ . To circumvent the high computing cost with large p and/or K, we propose a method below which requires to generate random variables from an  $\tilde{n}$ -variate normal distribution instead.

Let  $\Theta$  be an  $\tilde{n} \times \tilde{n}$  matrix with the (i, j)-th element  $\mathcal{K}\{(i - j)/b_n\}$ . Let  $\eta = (\eta_1, \dots, \eta_{\tilde{n}})^{\mathrm{T}} \sim N(0, \Theta)$  be a random vector independent of  $\{\varepsilon_1, \dots, \varepsilon_n\}$ . Then it is easy to see that conditionally on  $\{\varepsilon_1, \dots, \varepsilon_n\}$ ,

$$G = (I_K \otimes \widehat{W}) \left( \frac{1}{\sqrt{\tilde{n}}} \sum_{t=1}^{\tilde{n}} \eta_t f_t \right) \sim N(0, \widehat{\Xi}_n).$$
(11)

Thus a random sample from  $N(0, \widehat{\Xi}_n)$  can be obtained from a random sample from  $N(0, \Theta)$  via (11). The computational complexity of the new method is only  $O(n^3)$ , independent of p and K. The required storage space is also much smaller.

## **3** Theoretical properties

Write  $\varepsilon_t = (\varepsilon_{1,t}, \dots, \varepsilon_{p,t})^T$  for each  $t = 1, \dots, n$ . To investigate the theoretical properties of the proposed testing procedure, we need the following regularity conditions.

**Condition 1.** There exists a constant  $C_1 > 0$  independent of p such that  $var(\varepsilon_{i,t}) \ge C_1$  uniformly holds for any i = 1, ..., p.

**Condition 2.** There exist three constants  $C_2, C_3 > 0$  and  $r_1 \in (0, 2]$  independent of p such that  $\sup_t \sup_{1 \le i \le p} \operatorname{pr}(|\varepsilon_{i,t}| > x) \le C_2 \exp(-C_3 x^{r_1})$  for any x > 0.

**Condition 3.** Assume that  $\{\varepsilon_t\}$  is  $\beta$ -mixing in the sense that  $\beta_k \equiv \sup_t E\{\sup_{B \in \mathcal{F}_{t+k}^{\infty}} |\operatorname{pr}(B | \mathcal{F}_{-\infty}^t) - \operatorname{pr}(B)|\} \to 0$  as  $k \to \infty$ , where  $\mathcal{F}_{-\infty}^u$  and  $\mathcal{F}_{u+k}^{\infty}$  are the  $\sigma$ -fields generated respectively by  $\{\varepsilon_t\}_{t \leq u}$  and  $\{\varepsilon_t\}_{t \geq u+k}$ . Furthermore there exist two constants  $C_4 > 0$  and  $r_2 \in (0,1]$  independent of p such that  $\beta_k \leq \exp(-C_4k^{r_2})$  for all  $k \geq 1$ .

**Condition 4.** There exists a constant  $C_5 > 0$  and  $\iota > 0$  independent of p such that

$$C_5^{-1} < \liminf_{q \to \infty} \inf_{m \ge 0} E\left( \left| \frac{1}{q^{1/2}} \sum_{t=m+1}^{m+q} \varepsilon_{i,t+k} \varepsilon_{j,t} \right|^{2+\iota} \right)$$
  
$$\leq \limsup_{q \to \infty} \sup_{m \ge 0} E\left( \left| \frac{1}{q^{1/2}} \sum_{t=m+1}^{m+q} \varepsilon_{i,t+k} \varepsilon_{j,t} \right|^{2+\iota} \right) < C_5, \quad (i, j = 1, \dots, p; k = 1, \dots, K).$$

Condition 1 ensures that all component series are not degenerate. Condition 2 is a common assumption in the literature on ultra high-dimensional data analysis. It ensures exponential-type upper bounds for the tail probabilities of the statistics concerned. The  $\beta$ -mixing assumption in Condition 3 is mild. Causal autoregressive moving average processes with continuous innovation distributions are  $\beta$ -mixing with exponentially decaying  $\beta_k$ . So are the stationary Markov chains satisfying certain conditions. See Section 2.6.1 of Fan & Yao (2003) and the references within. In fact stationary generalized autoregressive conditional heteroskedasticity models with finite second moments and continuous innovation distributions are also  $\beta$ mixing with exponentially decaying  $\beta_k$ ; see Proposition 12 of Carrasco & Chen (2002). If we only require  $\sup_t \sup_{1 \le i \le p} \operatorname{pr}(|\varepsilon_{i,t}| > x) = O\{x^{-2(\nu+\epsilon)}\} \text{ for any } x > 0 \text{ in Condition 2 and } \beta_k = O\{k^{-\nu(\nu+\epsilon)/(2\epsilon)}\} \text{ in } x > 0 \text{ in Condition 2 and } \beta_k = O\{x^{-\nu(\nu+\epsilon)/(2\epsilon)}\} \text{ in } x > 0 \text{ in Condition 2 and } \beta_k = O\{x^{-\nu(\nu+\epsilon)/(2\epsilon)}\} \text{ in } x > 0 \text{ in Condition 2 and } \beta_k = O\{x^{-\nu(\nu+\epsilon)/(2\epsilon)}\} \text{ in } x > 0 \text{ in$ Condition 3 for some  $\nu > 2$  and  $\epsilon > 0$ , we can apply Fuk–Nagaev type inequalities to construct the upper bounds for the tail probabilities of the statistics for which our testing procedure still works for p diverging at some polynomial rate of n. We refer to Section 3.2 of arXiv:1410.2323 for the implementation of Fuk–Nagaev type inequalities in such a scenario. The  $\beta$ -mixing condition can be replaced by the  $\alpha$ -mixing condition under which we can justify the proposed method for p diverging at some polynomial rate of n by using Fuk–Nagaev type inequalities. However, it remains open to establish the relevant properties under  $\alpha$ -mixing for p diverging at some exponential rate of n. Condition 4 is a technical assumption for the validity of the Gaussian approximation for dependent data.

Our main asymptotic results indicate that the critical value  $\hat{cv}_{\alpha}$  defined in (7) by the normal approximation is asymptotically valid, and, furthermore, the proposed test is consistent.

**Theorem 1.** Let Conditions 1–4 hold,  $|\mathcal{K}(x)| \simeq |x|^{-\tau}$  as  $|x| \to \infty$  for some  $\tau > 1$ , and  $b_n \simeq n^{\rho}$  for some  $0 < \rho < \min\{(\tau - 1)/(3\tau), r_2/(2r_2 + 1)\}$ . Let  $\log p \le Cn^{\delta_2}$  for some positive constants  $\delta$ , C, and  $\delta$  depend on the constants in Conditions 1–4 only. Then it holds under  $H_0$  that

$$\operatorname{pr}(T_n > \widehat{\operatorname{cv}}_\alpha) \to \alpha, \quad n \to \infty.$$

**Theorem 2.** Assume that the conditions of Theorem 1 hold. Let  $\rho$  be the largest element in the main diagonal of  $\Xi_n$ , and  $\lambda(p, \alpha) = \{2 \log(p^2 K)\}^{1/2} + \{2 \log(1/\alpha)\}^{1/2}$ . Suppose that

$$\max_{1 \le k \le K} \max_{1 \le i, j \le p} |\rho_{i,j}(k)| \ge \varrho^{1/2} (1 + \epsilon_n) n^{-1/2} \lambda(p, \alpha)$$

for some positive  $\epsilon_n$  satisfying  $\epsilon_n \to 0$  and  $\epsilon_n^2 \log p \to \infty$ . Then it holds under  $H_1$  that

 $\operatorname{pr}(T_n > \widehat{\operatorname{cv}}_\alpha) \to 1, \quad n \to \infty.$ 

## **4** Numerical properties

#### 4.1 Preliminary

In this section, we illustrate the finite sample properties of the proposed test  $T_n$  by simulation. Also included is the test  $T_n^*$  based on the pre-transformed data as stated in Remark 1 in Section 2.1. We always use the quadratic spectral kernel  $\mathcal{K}_{QS}(x)$  specified in (10). In addition, we always use the data-driven bandwidth  $b_n = 1.3221\{\hat{a}(2)\tilde{n}\}^{1/5}$  suggested in Section 6 of Andrews (1991), where  $\hat{a}(2) = \{\sum_{\ell=1}^{p^2K} 4\hat{\rho}_{\ell}^2 \hat{\sigma}_{\ell}^4 (1 - \hat{\rho}_{\ell})^{-8}\}\{\sum_{\ell=1}^{p^2K} \hat{\sigma}_{\ell}^4 (1 - \hat{\rho}_{\ell})^{-4}\}^{-1}$  with  $\hat{\rho}_{\ell}$  and  $\hat{\sigma}_{\ell}^2$  being, respectively, the estimated autoregressive coefficient and innovation variance from fitting an AR(1) model to time series  $\{f_{\ell,t}\}_{t=1}^{\tilde{n}}$ , where  $f_{\ell,t}$  is the  $\ell$ -th component of  $f_t$  defined in (8). We draw  $G_1, \ldots, G_B$  independently from  $N(0, \hat{\Xi}_n)$  with B = 2000 based on (11) and

take the  $\lfloor B\alpha \rfloor$ -th largest value among  $|G_1|_{\infty}, \ldots, |G_B|_{\infty}$  as the critical value  $\widehat{cv}_{\alpha}$ . We set the nominal significance level at  $\alpha = 0.05$ , n = 300, p = 3, 15, 50, 150, and K = 2, 4, 6, 8, 10. For each setting, we replicate the experiment 500 times.

We compare the new tests  $T_n$  and  $T_n^*$  with three multivariate portmanteau tests with test statistics:  $Q_1 = n \sum_{k=1}^{K} \operatorname{tr}\{\widehat{\Gamma}(k)^{\mathrm{T}}\widehat{\Gamma}(k)\}$  (Box & Pierce, 1970),  $Q_2 = n^2 \sum_{k=1}^{K} \operatorname{tr}\{\widehat{\Gamma}(k)^{\mathrm{T}}\widehat{\Gamma}(k)\}/(n-k)$  (Hosking, 1980), and  $Q_3 = n \sum_{k=1}^{K} \operatorname{tr}\{\widehat{\Gamma}(k)^{\mathrm{T}}\widehat{\Gamma}(k)\} + p^2 K(K+1)/(2n)$  (Li & Mcleod, 1981), where  $\widehat{\Gamma}(k)$  is the sample correlation matrix (1). Also, we compare  $T_n$  and  $T_n^*$  with the Lagrange multiplier test (Lütkepohl, 2005), as well as a likelihood ratio test proposed by Tiao & Box (1981). The test of Tiao & Box (1981) is designed for testing for a vector autoregressive model of order r against that of order r + 1 and is therefore applicable for testing (3) with r = 0. In particular, different from all the other tests included in the comparison, the test of Tiao & Box (1981) does not involve the lag parameter K. For those tests relying on the asymptotic  $\chi^2$ -approximation, it is known that the  $\chi^2$ -approximation is poor when the degree of freedom is large. In our simulation, we perform those tests based on the normal approximation instead when p > 10. Further discussions on those tests are referred to Section 3.1 of Li (2004) and Section 4.4 of Lütkepohl (2005). The new tests  $T_n$  and  $T_n^*$ , together with the aforementioned other tests, have been implemented in an R package HDtest currently available online at CRAN.

### 4.2 Empirical sizes

To examine the approximations for significance levels of the tests, we generate data from the white noise model  $\varepsilon_t = Az_t$ , where  $\{z_t\}$  is a  $p \times 1$  white noise. We consider three different loading matrices for A as following.

Model 1: Let  $S = (s_{k\ell})_{1 \le k, \ell \le p}$  for  $s_{k\ell} = 0.995^{|k-\ell|}$ , then let  $A = S^{1/2}$ .

Model 2: Let  $r = \lceil p/2.5 \rceil$ ,  $S = (s_{k\ell})_{1 \le k, \ell \le p}$  where  $s_{kk} = 1$ ,  $s_{k\ell} = 0.8$  for  $r(q-1) + 1 \le k \ne \ell \le rq$  for  $q = 1, \ldots, \lfloor p/r \rfloor$ , and  $s_{k\ell} = 0$  otherwise. Let  $A = S^{1/2}$  which is a block diagonal matrix.

Model 3: Let  $A = (a_{k\ell})_{1 \le k, \ell \le p}$  with  $a_{k\ell}$ 's being independently generated from U(-1, 1).

We consider the two types of white noise: (i)  $z_t$ ,  $t \ge 1$ , are independent and  $N(0, I_p)$ , and (ii)  $z_t$  consists of p independent autoregressive conditionally heteroscedastic processes, i.e. each component process is of the form  $u_t = \sigma_t e_t$ , where  $e_t$  are independent and N(0, 1), and  $\sigma_t^2 = \gamma_0 + \gamma_1 u_{t-1}^2$  with  $\gamma_0$  and  $\gamma_1$  generated from, respectively, U(0.25, 0.5) and U(0, 0.5) independently for different component processes. Experiments with more complex white noise processes are reported in the Supplementary Material.

Tables 1–2 report the empirical sizes of tests  $T_n$  and  $T_n^*$ , along with those of the three portmanteau tests, the Lagrange multiplier test, and the test of Tiao & Box (1981). As Tiao & Box' test does not involve the lag parameter K, we only report its empirical size once for each p in the tables. Also the Lagrange multiplier test is only applicable when pK < n, as the testing statistic is calculated from a multivariate regression.

Tables 1–2 indicate that  $T_n$  and  $T_n^*$  perform about the same as the other five tests when the dimension p is small, such as p = 3. The portmanteau, Lagrange multiplier and Tiao & Box's tests, however, fail badly to attain the nominal significance level as the dimension p increases, as the empirical sizes severely underestimate the nominal level when, for example, p = 50. In fact the empirical sizes for the portmanteau tests and Tiao & Box's test are almost 0 under all the settings with p = 150, while the Lagrange multiplier test, not available when p = 150, deviates quickly from the nominal level when pK is close to n. In contrast, the new test  $T_n$  performs much better, though still underestimates the nominal level when p is relatively large, particularly for Model 3. Noticeably,  $T_n^*$ , the procedure combining the new test with the time series principal

Table 1: The empirical sizes (%) of the tests  $T_n$ ,  $T_n^*$ ,  $Q_1$ ,  $Q_2$ ,  $Q_3$ , Lagrange multiplier test (LM) and Tiao & Box' test (TB) for testing white noise  $\varepsilon_t = Az_t$  at the 5% nominal level, where  $z_t$ ,  $t \ge 1$ , are independent and  $N(0, I_p)$ .

		Model 1							Model 2								Model 3						
p	K	$T_n$	$T_n^*$	$Q_1$	$Q_2$	$Q_3$	LM	TB	$T_n$	$T_n^*$	$Q_1$	$Q_2$	$Q_3$	LM	TB	$T_n$	$T_n^*$	$Q_1$	$Q_2$	$Q_3$	LM	TB	
3	2	5.2	5.8	5.2	5.6	5.6	5.2	5.2	3.2	6.6	3.8	3.8	3.8	3.8	4.8	4.0	6.4	4.0	4.0	4.0	5.2	3.8	
	4	4.6	7.4	3.6	4.4	4.2	4.4		4.0	7.4	3.2	3.4	3.4	3.6		3.8	5.4	4.8	5.0	5.0	5.4		
	6	5.6	8.6	4.4	5.2	5.0	5.4		2.8	7.2	3.2	3.6	3.4	3.0		4.0	5.4	6.0	6.4	6.2	5.2		
	8	4.4	8.4	3.6	5.0	4.4	3.0		3.8	6.2	2.6	3.0	2.8	3.2		3.8	6.4	5.0	6.8	6.2	4.6		
	10	4.2	7.8	3.6	4.4	4.2	4.0		3.0	6.0	1.4	3.0	2.4	2.4		3.6	5.6	5.4	7.4	7.2	4.6		
15	2	3.8	5.2	4.2	4.8	4.8	5.0	4.8	2.8	4.4	4.2	5.0	5.0	5.4	7.6	3.0	3.8	3.4	4.0	4.0	3.8	5.2	
	4	4.0	5.4	2.8	5.0	5.0	3.8		2.6	4.2	2.8	4.6	4.6	3.6		2.4	4.8	2.2	3.0	3.0	3.2		
	6	3.6	6.2	3.2	5.2	5.2	3.8		2.2	5.2	3.4	5.2	5.0	3.4		2.0	5.8	1.6	3.2	3.2	2.4		
	8	3.6	6.6	2.0	5.2	5.0	1.0		2.4	6.0	0.8	5.0	4.6	2.0		2.2	7.2	0.8	2.8	2.8	1.4		
	10	3.0	7.0	1.4	5.6	5.2	0.4		2.2	6.2	1.0	5.0	4.8	1.6		2.6	6.6	1.0	4.0	3.8	0.8		
50	2	2.4	4.0	1.6	2.4	2.4	1.2	8.8	3.0	4.2	1.4	2.4	2.4	1.4	7.8	1.8	4.8	1.6	2.8	2.8	1.2	7.8	
	4	4.0	4.4	0.6	3.0	2.8	0.0		2.6	4.6	0.6	2.2	2.2	0.0		2.2	5.2	0.8	2.6	2.6	0.0		
	6	3.6	4.8	0.0	3.8	3.6			1.8	5.2	0.2	2.8	2.6			2.0	6.4	0.2	2.2	2.2			
	8	3.8	4.4	0.0	3.8	3.6			2.0	5.4	0.0	2.2	2.2			1.6	7.2	0.0	2.8	2.4			
	10	4.6	4.8	0.0	3.0	3.0			1.4	5.4	0.0	2.8	2.2			1.4	6.2	0.0	2.0	1.8			
150	2	3.0	4.4	0.0	0.0	0.0		0.0	3.0	3.8	0.0	0.2	0.0		0.0	1.4	3.6	0.0	0.2	0.2		0.0	
	4	1.4	4.2	0.0	0.0	0.0			2.0	4.2	0.0	0.0	0.0			1.4	3.4	0.0	0.0	0.0			
	6	1.8	2.8	0.0	0.0	0.0			2.4	3.2	0.0	0.0	0.0			1.2	4.2	0.0	0.0	0.0			
	8	2.2	3.8	0.0	0.0	0.0			1.8	3.2	0.0	0.2	0.2			0.6	4.8	0.0	0.0	0.0			
	10	3.2	4.6	0.0	0.2	0.0			1.6	4.2	0.0	0.0	0.0			0.4	5.4	0.0	0.0	0.0			

Table 2: The empirical sizes (%) of the tests  $T_n$ ,  $T_n^*$ ,  $Q_1$ ,  $Q_2$ ,  $Q_3$ , Lagrange multiplier test (LM) and Tiao & Box' test (TB) for testing white noise  $\varepsilon_t = Az_t$  at the 5% nominal level, where  $z_t$  consists of p independent autoregressive conditionally heteroscedastic processes.

		Model 1						Model 2								Model 3						
p	K	$T_n$	$T_n^*$	$Q_1$	$Q_2$	$Q_3$	LM	TB	$T_n$	$T_n^*$	$Q_1$	$Q_2$	$Q_3$	LM	TB	$T_n$	$T_n^*$	$Q_1$	$Q_2$	$Q_3$	LM	TB
3	2	4.0	5.4	3.0	3.0	4.2	4.0	4.4	6.4	8.6	7.0	7.0	9.4	8.4	6.4	3.8	7.2	5.4	5.6	8	6.6	7.2
	4	4.4	7.6	4.4	4.6	5.2	5.0		5.6	8.2	5.2	6.0	7.4	6.2		5.0	7.8	5.4	6.0	8.2	7.2	
	6	3.0	6.6	4.8	5.6	6.4	4.6		5.0	6.6	5.8	6.2	7.2	4.8		4.8	6.8	4.0	4.4	6.6	4.8	
	8	3.2	6.4	4.4	5.8	7.4	5.6		4.6	6.8	5.8	7.0	7.8	6.4		4.8	6.6	4.2	5.0	5.4	3.4	
	10	3.6	6.0	5.0	5.8	7.8	5.6		4.4	6.2	5.4	6.4	7.2	4.2		4.8	5.8	4.6	5.0	5.4	4.0	
15	2	4.2	5.6	4.0	3.8	4.6	5.0	7.0	4.8	5.0	3.2	3.2	3.6	3.4	5.6	2.4	4.8	5.0	5.4	6.6	5.2	6.8
	4	4.0	5.8	5.0	5.0	5.2	4.0		3.8	5.0	4.0	4.0	4.0	2.2		2.6	7.0	2.8	2.8	2.8	3.2	
	6	4.2	5.0	4.2	4.0	4.2	3.0		2.8	6.2	5.6	5.0	5.6	2.0		2.4	6.8	3.0	3.0	3.2	2.6	
	8	3.8	6.0	4.8	4.8	4.8	1.4		2.2	5.8	4.8	4.8	4.8	2.0		2.8	6.2	1.8	2.8	3.8	2.2	
	10	4.6	4.8	5.6	5.4	5.4	1.2		3.4	5.4	4.0	3.8	4.4	1.4		2.4	8.2	0.8	4.2	4.4	0.8	
50	2	4.4	4.2	2.2	2.2	2.2	0.6	6.2	3.2	4.0	1.4	2.4	2.8	1.0	8.2	2.2	3.2	2.2	2.0	2.0	0.4	7.6
	4	3.8	4.6	2.8	2.8	3.0	0.0		2.2	5.4	2.0	2.0	2.0	0.0		2.2	4.0	2.0	1.8	1.8	0.0	
	6	4.6	6.2	1.4	1.4	1.8			3.6	5.2	1.8	2.8	1.8			1.2	4.8	2.0	2.0	2.0		
	8	3.6	7.2	3.0	3.0	3.0			2.4	6.0	1.4	1.2	1.6			1.6	5.8	0.0	0.0	1.6		
	10	3.6	5.8	3.2	3.2	2.8			2.2	5.6	1.8	1.8	1.8			1.4	6.6	0.0	0.0	1.6		
150	2	4.8	3.6	0.0	0.0	0.0		0.0	1.2	2.8	0.0	0.0	0.0		0.2	1.6	2.8	0.0	0.0	0.0		0.0
	4	2.8	3.2	0.0	0.0	0.0			2.2	3.4	0.0	0.0	0.0			1.0	3.2	0.2	0.0	0.2		
	6	2.0	4.2	0.0	0.0	0.0			2.6	3.6	0.0	0.0	0.0			1.0	3.2	0.0	0.0	0.0		
	8	1.6	5.0	0.0	0.0	0.0			1.6	4.4	0.0	0.0	0.0			0.8	3.4	0.2	0.0	0.2		
	10	2.6	4.8	0.2	0.2	0.2			2.0	5.0	0.4	0.2	0.4			1.0	4.6	0.0	0.0	0.0		

component analysis, produces empirical sizes much closer to the nominal level than all other tests across almost all the settings with p = 50 and 150.

We also observe that both the portmanteau tests  $Q_2$  and  $Q_3$  perform similarly, and outperform  $Q_1$  when p is large. This is in line with the fact that the asymptotic approximations for  $Q_2$  and  $Q_3$  are more accurate than that for  $Q_1$ . In addition, Tables 1–2, as well as the results in the Supplementary Material, indicate that the proposed tests are more robust with respect to the choice of the prescribed lag parameter K. The test  $T_n$ , and the portmanteau tests, perform better under Models 1 and 2 than under Model 3 when p is large. As the entries in the loading matrix A in Model 3 can be both positive and negative, the signals  $z_t$  may be weakened due to possible cancellations. Nevertheless, with the aid of time series principal component analysis,  $T_n^*$  perform reasonably well across all the settings including Model 3.

In summary, the proposed tests, especially  $T_n^*$ , attain the nominal level much more accurate than existing tests when p is large. For small p, all the tests are about equally accurate in attaining the nominal significance level.

### 4.3 Empirical power

To conduct the power comparison among the different tests, we consider two non-white noise models. Put  $k_0 = \min(\lfloor p/5 \rfloor, 12)$ .

- Model 4:  $\varepsilon_t = A\varepsilon_{t-1} + e_t$ , where  $e_t, t \ge 1$ , are independent, each  $e_t$  consists of p independent  $t_8$  random variables, and the coefficient matrix  $A \equiv (a_{k\ell})$  is generated as follows:  $a_{k\ell} \sim U(-0.25, 0.25)$  independently for  $1 \le k, \ell \le k_0$ , and  $a_{k\ell} = 0$  otherwise. Thus only the first  $k_0$  components of  $\varepsilon_t$  are not white noise.
- Model 5:  $\varepsilon_t = Az_t$ , where  $z_t = (z_{1,t}, \ldots, z_{p,t})^{\mathrm{T}}$ . For  $1 \leq k \leq k_0, (z_{k,1}, \ldots, z_{k,n})^{\mathrm{T}} \sim N(0, \Sigma)$ , where  $\Sigma$  is an  $n \times n$  matrix with 1 as the main diagonal elements,  $0.5|i-j|^{-0.6}$  as the (i, j)-th element for  $1 \leq |i-j| \leq 7$ , and 0 as all the other elements. For  $k > k_0, z_{k,1}, \ldots, z_{k,n}$  are independent and  $t_8$  random variables. The coefficient matrix  $A \equiv (a_{k\ell})$  is generated as follows:  $a_{k\ell} \sim U(-1, 1)$  with probability 1/3 and  $a_{k\ell} = 0$  with probability 2/3 independently for  $1 \leq k \neq \ell \leq p$ , and  $a_{kk} = 0.8$  for  $1 \leq k \leq p$ .

Figs. 1–2 display the empirical power curves of the seven tests under consideration against the lag parameter K. As Tiao & Box' test involves no lag parameter K, its power curves are flat. Also note that the Lagrange multiplier test is only available for p = 3, 15 and p = 50 while K = 2, 4, 6. When p = 150, the proposed tests, especially  $T_n^*$ , maintain substantial power while all the other five tests are powerless. Under Model 4, where the autocorrelation decays relatively fast, the proposed tests  $T_n$  and  $T_n^*$  are substantially more powerful than the portmanteau tests and the Lagrange multiplier test even when p is small. In addition, Fig. 1 and the results in the Supplementary Materials also indicate that the existing tests compromise more in power than the new tests when the loading matrix A is relatively sparse. When the autocorrelation is strong, as in Model 5, the portmanteau tests and the Lagrange multiplier test perform well when p is small, e.g., p = 3; see Fig. 2. Finally, as expected,  $T_n^*$  is more powerful than  $T_n$  when p is large, and the improvement is substantial when, for example, p = 150. Overall, our proposed tests  $T_n$  and  $T_n^*$  are more powerful than the traditional tests when the dimension p is large or moderately large. This pattern is also observed in a more extensive comparison reported in the Supplementary Material.



Figure 1: Plots of empirical power against lag K for the new tests  $T_n$  (solid and  $\blacksquare$  lines) and  $T_n^*$  (solid and  $\bullet$  lines), the portmanteau tests  $Q_1$  (dashed and  $\triangle$  lines),  $Q_2$  (dashed and + lines) and  $Q_3$  (dashed and  $\Box$  lines), the Lagrange multiplier test (dashed and  $\circ$  lines), and Tiao and Box' test (dashed and  $\times$ ). The data are generated from Model 4 with sample size n = 300. The nominal level is  $\alpha = 5\%$ .

## 5 Applications in model diagnosis

Let  $\{y_t\}$  and  $\{u_t\}$  be observable  $p \times 1$  and  $q \times 1$  time series, respectively. Let

$$y_t = g(u_t; \theta_0) + \varepsilon_t, \tag{12}$$

where  $g(\cdot; \cdot)$  is a known link function, and  $\theta_0 \in \Theta$  is an unknown  $s \times 1$  parameter vector. One of the most frequently used procedures for model diagnosis is to test if the error process  $\{\varepsilon_t\}$  is white noise. Since  $\{\varepsilon_t\}$  is unknown, the diagnostic test is instead applied to the residuals

$$\widehat{\varepsilon}_t \equiv y_t - g(u_t; \theta), \qquad t = 1, \cdots, n,$$
(13)

where  $\hat{\theta}$  is an appropriate estimator for  $\theta_0$ .

Model (12) encompasses a large number of frequently used models, including both linear and nonlinear vector autoregressive models with or without exogenous variables. It also includes linear invertible and identifiable vector autoregressive and moving average models by allowing  $q = \infty$  and  $s = \infty$ . Let  $g(\cdot; \cdot) = \{g_1(\cdot; \cdot), \ldots, g_p(\cdot; \cdot)\}^T$ , and  $\mathcal{U}$  be the domain of  $u_t$ . Let the true value  $\theta_0$  of model (12) be an inner point of  $\Theta$ . We assume that the link function  $g(\cdot; \cdot)$  satisfies the following condition.

**Condition 5.** Denote by  $\Theta_0$  a small neighborhood of  $\theta_0$ . For some given metric  $|\cdot|_*$  defined on  $\Theta$ , it holds that  $|g_i(u;\theta^*)-g_i(u;\theta^{**})| \leq M_i(u)|\theta^*-\theta^{**}|_*+R_i(u;\theta^*,\theta^{**})$  for any  $\theta^*,\theta^{**} \in \Theta_0$ ,  $u \in \mathcal{U}$  and i = 1, ..., p, where  $\{M_i(\cdot)\}_{i=1}^p$  and  $\{R_i(\cdot;\cdot,\cdot)\}_{i=1}^p$  are two sets of non-negative functions that



Figure 2: Plots of empirical power against lag K for the new tests  $T_n$  (solid and  $\blacksquare$  lines) and  $T_n^*$  (solid and  $\bullet$  lines), the portmanteau tests  $Q_1$  (dashed and  $\triangle$  lines),  $Q_2$  (dashed and + lines) and  $Q_3$  (dashed and  $\Box$  lines), the Lagrange multiplier test (dashed and  $\circ$  lines), and Tiao and Box' test (dashed and  $\times$ ). The data are generated from Model 5 with sample size n = 300. The nominal level is  $\alpha = 5\%$ .

satisfy  $\sup_{1 \le i \le p} n^{-1} \sum_{t=1}^{n} M_i^2(u_t) = O_p(\varphi_{1,n})$  and  $\sup_{1 \le i \le p} \sup_{\theta^*, \theta^{**} \in \Theta_0} n^{-1} \sum_{t=1}^{n} R_i^2(u_t; \theta^*, \theta^{**}) = O_p(\varphi_{2,n})$  for some  $\varphi_{1,n} > 0$  (which may diverge) and  $\varphi_{2,n} \to 0$  as  $n \to \infty$ .

In fact, the first part of Condition 5 can be replaced by the Lipschitz continuity  $|g_i(u;\theta^*) - g_i(u;\theta^{**})| \leq M_i(u)|\theta^* - \theta^{**}|_*^{\phi} + R_i(u;\theta^*,\theta^{**})$  for some  $\phi \in (0,1]$ . Since the proofs for Theorem 3 under these two types of continuity are identical, we only state the result for  $\phi = 1$  explicitly. The remainder term  $R_i(\cdot;\cdot,\cdot)$  is employed to accommodate the models with infinite-dimensional parameter  $\theta_0$ . When  $\theta_0$  has finite number of components, we can let  $|\cdot|_*$  be the standard  $L_2$ -norm. If the link function  $g_i(u;\theta)$  is continuously differentiable with respect to  $\theta$ , it follows from a Taylor expansion that  $|g_i(u;\theta^*) - g_i(u;\theta^{**})| \leq |\nabla_\theta g_i(u;\bar{\theta})|_2 |\theta^* - \theta^{**}|_2$  for some  $\bar{\theta}$  lies between  $\theta^*$  and  $\theta^{**}$ . If there exists an envelop function  $M_i(\cdot)$  satisfying  $\sup_{\theta \in \Theta} |\nabla_\theta g_i(u;\bar{\theta})|_2 \leq M_i(u)$  for any  $u \in \mathcal{U}$ , the first part of Condition 5 holds with  $R_i(u;\theta^*,\theta^{**}) \equiv 0$ . When  $\theta_0$  is an infinite dimensional parameter, we can select  $|\cdot|_*$  as the vector  $L_1$ -norm. Put  $\theta = (\theta_1, \theta_2, \ldots)^{\mathrm{T}}$ . If  $\partial g_i(u;\theta)/\partial \theta_j$  exists for any  $j = 1, 2, \ldots$ , it follows from a Taylor expansion that  $g_i(u;\theta^*) - g_i(u;\theta^{**}) = \sum_{j=1}^{\infty} (\theta_j^* - \theta_j^{**}) \partial g_i(u;\bar{\theta})/\partial \theta_j$  for some  $\bar{\theta}$  lies between  $\theta^*$  and  $\theta^{**}$ . For some given diverging d, letting  $M_i(u) = \sup_{1 \le j \le d} \sup_{\theta \in \Theta} |\partial g_i(u;\theta)/\partial \theta_j|$  and  $R_i(u;\theta^*,\theta^{**}) = |\sum_{j=d+1}^{\infty} (\theta_j^* - \theta_j^{**}) \partial g_i(u;\bar{\theta})/\partial \theta_j|$ , we have

$$|g_i(u;\theta^*) - g_i(u;\theta^{**})| \le \sup_{1\le j\le d} \left|\frac{\partial g_i(u;\bar{\theta})}{\partial \theta_j}\right| \sum_{j=1}^d |\theta_j^* - \theta_j^{**}| + \left|\sum_{j=d+1}^\infty (\theta_j^* - \theta_j^{**})\frac{\partial g_i(u;\bar{\theta})}{\partial \theta_j}\right| \le M_i(u)|\theta^* - \theta^{**}|_1 + R_i(u;\theta^*,\theta^{**}).$$

**Theorem 3.** Let Condition 5 and the conditions of Theorems 1 and 2 hold. Let  $|\hat{\theta} - \theta_0|_* = O_p(\zeta_n)$  for some  $\zeta_n \to 0$ . Assume that  $\zeta_n^2 \varphi_{1,n} \to 0$  as  $n \to \infty$ . Then Theorems 1 and 2 still hold if  $\{\varepsilon_1, \dots, \varepsilon_n\}$  is replaced by  $\{\widehat{\varepsilon}_1, \dots, \widehat{\varepsilon}_n\}$  defined in (13).

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## Supplementary material

Supplementary material available at Biometrika online contains more extensive comparison by simulation of the seven tests employed in Section 4.

# Appendix

#### A.1 Technical lemmas

Let

$$\widehat{\mu} = [\operatorname{vec}\{\widehat{\Gamma}(1)\}^{\mathrm{T}}, \dots, \operatorname{vec}\{\widehat{\Gamma}(K)\}^{\mathrm{T}}]^{\mathrm{T}}, \quad \widehat{W} = \operatorname{diag}\{\widehat{\Sigma}(0)\}^{-1/2} \otimes \operatorname{diag}\{\widehat{\Sigma}(0)\}^{-1/2}.$$

Then the testing statistic  $T_n = n^{1/2} |\hat{\mu}|_{\infty}$ . It follows from (1) that

$$\widehat{\mu} \equiv (\widehat{\mu}_1, \dots, \widehat{\mu}_{p^2 K})^{\mathrm{T}} = (I_K \otimes \widehat{W}) [\operatorname{vec}\{\widehat{\Sigma}(1)\}^{\mathrm{T}}, \dots, \operatorname{vec}\{\widehat{\Sigma}(K)\}^{\mathrm{T}}]^{\mathrm{T}}.$$

Let

$$\mu \equiv (\mu_1, \dots, \mu_{p^2 K})^{\mathrm{T}} = (I_K \otimes W) [\operatorname{vec}\{\widehat{\Sigma}(1)\}^{\mathrm{T}}, \dots, \operatorname{vec}\{\widehat{\Sigma}(K)\}^{\mathrm{T}}]^{\mathrm{T}},$$
$$\widehat{Z} = n^{1/2} \max_{1 \le \ell \le p^2 K} \widehat{\mu}_{\ell}, \qquad Z = n^{1/2} \max_{1 \le \ell \le p^2 K} \mu_{\ell}, \qquad V = \max_{1 \le \ell \le p^2 K} G_{\ell}$$

where  $G = (G_1, \ldots, G_{p^2K})^{\mathrm{T}} \sim N(0, \Xi_n)$  with  $\Xi_n$  specified in (6). Throughout the Appendix,  $C \in (0, \infty)$  denotes a generic constant that does not depend on p and n, and it may be different at different places.

**Lemma 1.** Assume that Conditions 1–3 hold. Let  $\gamma$  satisfy  $\gamma^{-1} = 2r_1^{-1} + r_2^{-1}$ , and  $\log p = o\{n^{\gamma/(2-\gamma)}\}$ . Then  $|\widehat{W} - W|_{\infty} \leq Cn^{-1/2}(\log p)^{1/2}$  with probability at least  $1 - Cp^{-1}$ .

*Proof.* Put diag{ $\widehat{\Sigma}(0)$ } = diag( $\widehat{\sigma}_1^2, \ldots, \widehat{\sigma}_p^2$ ) and diag{ $\Sigma(0)$ } = diag( $\sigma_1^2, \ldots, \sigma_p^2$ ). By Condition 1,

$$|\widehat{W} - W|_{\infty} = \max_{1 \le i, j \le p} |\widehat{\sigma}_i^{-1} \widehat{\sigma}_j^{-1} - \sigma_i^{-1} \sigma_j^{-1}| \le \left(\max_{1 \le i \le p} |\widehat{\sigma}_i^{-1} - \sigma_i^{-1}|\right)^2 + C \max_{1 \le i \le p} |\widehat{\sigma}_i^{-1} - \sigma_i^{-1}|.$$
(14)

To bound the term on the right-hand side of (14), we first consider the tail probability of  $\max_{1 \le i \le p} |\hat{\sigma}_i - \sigma_i|$ . Following the same arguments of Lemma 9 in arXiv:1410.2323, it holds that

$$\Pr\left(\max_{1 \le i \le p} |\widehat{\sigma}_i^2 - \sigma_i^2| > \varepsilon\right) \le Cpn \exp(-C\varepsilon^{\gamma} n^{\gamma}) + Cpn \exp(-C\varepsilon^{\tilde{\gamma}/2} n^{\tilde{\gamma}}) \\ + Cp \exp(-C\varepsilon^2 n) + Cp \exp(-C\varepsilon n)$$

for any  $\varepsilon > 0$  such that  $n\varepsilon \to \infty$ , where  $\tilde{\gamma}^{-1} = r_1^{-1} + r_2^{-1}$ . Therefore, if  $\log p = o\{n^{\gamma/(2-\gamma)}\}$ , with probability at least  $1 - Cp^{-1}$ ,  $\max_{1 \le i \le p} |\hat{\sigma}_i^2 - \sigma_i^2| \le Cn^{-1/2}(\log p)^{1/2}$ . Since  $\hat{\sigma}_i^2 - \sigma_i^2 = (\hat{\sigma}_i - \sigma_i)^2 + 2\sigma_i(\hat{\sigma}_i - \sigma_i)$ , it holds with probability at least  $1 - Cp^{-1}$  that  $\max_{1 \le i \le p} |\hat{\sigma}_i - \sigma_i| \le Cn^{-1/2}(\log p)^{1/2}$ . Finally, it follows from the identify  $\hat{\sigma}_i^{-1} - \sigma_i^{-1} = -(\hat{\sigma}_i - \sigma_i)\hat{\sigma}_i^{-1}\sigma_i^{-1}$  that  $\max_{1 \le i \le p} |\hat{\sigma}_i^{-1} - \sigma_i^{-1}| \le Cn^{-1/2}(\log p)^{1/2}$  holds with probability at least  $1 - Cp^{-1}$ . Now the lemma follows from (14) immediately.

**Lemma 2.** Assume that Conditions 1–3 hold. Let  $\gamma^{-1} = 2r_1^{-1} + r_2^{-1}$  and  $\tilde{\gamma}^{-1} = r_1^{-1} + r_2^{-1}$ . Then

$$\Pr\left[\max_{1 \le k \le K} |\operatorname{vec}\{\widehat{\Sigma}(k)\} - \operatorname{vec}\{\Sigma(k)\}|_{\infty} > s\right] \le Cp^2 n \exp(-Cs^{\gamma}n^{\gamma}) + Cp^2 n \exp(-Cs^{\tilde{\gamma}/2}n^{\tilde{\gamma}}) + Cp^2 \exp(-Cs^2n) + Cp^2 \exp(-Csn)$$

for any s > 0 and  $ns \to \infty$ .

*Proof.* Notice that  $|\operatorname{vec}\{\widehat{\Sigma}(k)\} - \operatorname{vec}\{\Sigma(k)\}|_{\infty} = \max_{1 \le i,j \le p} |\widehat{\sigma}_{i,j}(k) - \sigma_{i,j}(k)|$ . For given  $k = 1, \ldots, K$ , Lemma 9 in arXiv:1410.2323 implies that

$$\begin{aligned} \Pr\left[|\operatorname{vec}\{\widehat{\Sigma}(k)\} - \operatorname{vec}\{\Sigma(k)\}|_{\infty} > s\right] &\leq Cp^2 n \exp(-Cs^{\gamma}n^{\gamma}) + Cp^2 n \exp(-Cs^{\tilde{\gamma}/2}n^{\tilde{\gamma}}) \\ &+ Cp^2 \exp(-Cs^2n) + Cp^2 \exp(-Csn) \end{aligned}$$

for any s > 0 and  $ns \to \infty$ . Consequently, the lemma follows directly from the Bonferroni inequality.  $\Box$ 

**Lemma 3.** Assume that Conditions 1–3 hold. Let  $\gamma^{-1} = 2r_1^{-1} + r_2^{-1}$  and  $\log p = o\{n^{\gamma/(2-\gamma)}\}$ . Then it holds under null hypothesis  $H_0$  that  $|\hat{Z} - Z| \leq Cn^{-1/2} \log p$  with probability at least  $1 - Cp^{-1}$ .

*Proof.* Note that  $|\widehat{Z}-Z| \leq |\widehat{W}-W|_{\infty} \max_{1 \leq k \leq K} n^{1/2} |\operatorname{vec}\{\widehat{\Sigma}(k)\}|_{\infty}$ . By Lemma A2, we have  $\max_{1 \leq k \leq K} |\operatorname{vec}\{\widehat{\Sigma}(k)\}|_{\infty} \leq Cn^{-1/2} (\log p)^{1/2}$  with probability at least  $1 - Cp^{-1}$  under  $H_0$ . This, together with Lemma A1, implies the required assertion.

**Lemma 4.** Assume that Conditions 1–4 hold. Let  $\log p \leq Cn^{\delta}$  for some  $\delta > 0$ . Then it holds under  $H_0$  that  $\sup_{s \in \mathbb{R}} |\operatorname{pr}(Z \leq s) - \operatorname{pr}(V \leq s)| = o(1)$ .

*Proof.* It follow from (2) that  $\mu = n^{-1} \sum_{t=1}^{\tilde{n}} u_t + R_n$ , where  $\tilde{n} = n - K$ , each element of  $u_t$  has the form  $x_{i,t+k}x_{j,t}/(\sigma_i\sigma_j)$ , and  $R_n$  is the remainder term. Let  $\tilde{\beta}_k$   $(k \ge 1)$  be the  $\beta$ -mixing coefficients generated by the process  $\{u_t\}$ . Obviously, it holds that  $\tilde{\beta}_k \le \beta_{(k-K)^+}$ . Define  $\bar{u} = \tilde{n}^{-1} \sum_{t=1}^{\tilde{n}} u_t \equiv (\bar{u}_1, \ldots, \bar{u}_{p^2K})^{\mathrm{T}}$  and  $\tilde{Z} = \tilde{n}^{1/2} \max_{1 \le \ell \le p^2K} \bar{u}_\ell$ . In addition, let  $d_n = \sup_{s \in \mathbb{R}} |\operatorname{pr}(Z \le s) - \operatorname{pr}(V \le s)|$  and  $\tilde{d}_n = \sup_{s \in \mathbb{R}} |\operatorname{pr}(\tilde{Z} \le s) - \operatorname{pr}(V \le s)|$ . We proceed the proof for  $d_n = o(1)$  in two steps: (i) to show  $d_n \le \tilde{d}_n + o(1)$ , and (ii) to prove  $\tilde{d}_n = o(1)$ .

To prove (i), note that for any  $s \in \mathbb{R}$  and  $\varepsilon > 0$ ,

$$pr(Z \le s) - pr(V \le s) \le pr(\widetilde{Z} \le s + \varepsilon) - pr(V \le s + \varepsilon) + pr(|Z - \widetilde{Z}| > \varepsilon) + pr(s < V \le s + \varepsilon)$$
$$\le \widetilde{d}_n + pr(|Z - \widetilde{Z}| > \varepsilon) + pr(s < V \le s + \varepsilon).$$

Similarly, we can obtain the reverse inequality. Therefore,

$$d_n \le \widetilde{d}_n + \operatorname{pr}(|Z - \widetilde{Z}| > \varepsilon) + \sup_{s \in \mathbb{R}} \operatorname{pr}(|V - s| \le \varepsilon).$$
(15)

By the anti-concentration inequality of Gaussian random variables,  $\sup_{s \in \mathbb{R}} \operatorname{pr}(|V-s| \le \varepsilon) \le C \varepsilon \{\log(p/\varepsilon)\}^{1/2}$ . It follows from the triangle inequality and Condition 1 that

$$|Z - \widetilde{Z}| \le (n^{1/2} - \widetilde{n}^{1/2}) \max_{1 \le \ell \le p^2 K} |\mu_{\ell}| + \widetilde{n}^{1/2} \max_{1 \le \ell \le p^2 K} |\mu_{\ell} - \overline{u}_{\ell}|$$
  
$$\le \frac{C}{n^{1/2}} \max_{1 \le k \le K} |\operatorname{vec}\{\widehat{\Sigma}(k)\}|_{\infty} + \frac{C}{n^{1/2}} |\overline{u}|_{\infty} + n^{1/2} |R_n|_{\infty}.$$

Following the arguments of Lemma 9 of arXiv:1410.2323, we can show that under  $H_0$ ,

$$\begin{aligned} \Pr\left(\frac{C}{n^{1/2}}|\bar{u}|_{\infty} > \frac{\varepsilon}{3}\right) &\leq Cp^2 n \exp(-C\varepsilon^{\gamma} n^{3\gamma/2}) + Cp^2 n \exp(-C\varepsilon^{\tilde{\gamma}/2} n^{5\tilde{\gamma}/4}) \\ &+ Cp^2 \exp(-C\varepsilon^2 n^2) + Cp^2 \exp(-C\varepsilon n^{3/2}) \,, \end{aligned}$$

provided  $n^3 \varepsilon^2 \to \infty$ . It can also shown in the same manner that under  $H_0$ ,  $\operatorname{pr}(n^{1/2}|R_n|_{\infty} > \varepsilon/3)$  can be also controlled by the same upper bound specified above. Now by Lemma A2, it holds under  $H_0$  that

$$\begin{aligned} \Pr(|Z - \widetilde{Z}| > \varepsilon) &\leq Cp^2 n \exp(-C\varepsilon^{\gamma} n^{3\gamma/2}) + Cp^2 n \exp(-C\varepsilon^{\tilde{\gamma}/2} n^{5\tilde{\gamma}/4}) \\ &+ Cp^2 \exp(-C\varepsilon^2 n^2) + Cp^2 \exp(-C\varepsilon n^{3/2}). \end{aligned}$$

Let  $\varepsilon = Cn^{-1}(\log p)^{1/2}$ . Then (15) implies that  $d_n \leq \tilde{d}_n + o(1)$ .

The proof of (ii) is the same as that to show  $d_1 = o(1)$  in the proof of Theorem 1 of an unpublished technical report of Chang, Qiu, Yao and Zou (arXiv:1603.06663). Therefore, if  $\log p \leq Cn^{\delta}$  for some  $\delta > 0$ , we have  $\tilde{d}_n = o(1)$ . This completes the proof of Lemma A4.

#### A.2 Proof of Proposition 1

Following the arguments in the proof of Proposition 1 in the supplementary file of an unpublished technical report of Chang, Zhou and Zhou (arXiv:1406.1939), it suffices to show  $\sup_{s\in\mathbb{R}} |\operatorname{pr}(\widehat{Z} > s) - \operatorname{pr}(V > s)| = o(1)$ , where  $\widehat{Z}$  and V are defined in the first paragraph of Appendix. Recall  $d_n = \sup_{s\in\mathbb{R}} |\operatorname{pr}(Z \le s) - \operatorname{pr}(V \le s)|$ . By the similar arguments of (15), it can be proved that  $\sup_{s\in\mathbb{R}} |\operatorname{pr}(\widehat{Z} > s) - \operatorname{pr}(V > s)| \le d_n + \operatorname{pr}(|\widehat{Z} - Z| > \varepsilon) + C\varepsilon \{\log(p/\varepsilon)\}^{1/2}$ . Set  $\varepsilon = Cn^{-1/2}\log p$ , Lemmas A3 and A4 yield that  $\sup_{s\in\mathbb{R}} |\operatorname{pr}(\widehat{Z} > s) - \operatorname{pr}(V > s)| \le s) - \operatorname{pr}(V > s)| = o(1)$ . This completes the proof of Theorem 1.

#### A.3 Proof of Theorem 1

Based on Lemma 4 of arXiv:1603.06663 and Proposition 1, we can proceed the proof in the same manner as the proof for Theorem 2 of arXiv:1603.06663.

## A.4 Proof of Theorem 2

Let  $\mathcal{X}_n = \{\varepsilon_1, \ldots, \varepsilon_n\}$ . Since  $G \sim N(0, \widehat{\Xi}_n)$  conditionally on  $\mathcal{X}_n$ , it holds that

$$E(|G|_{\infty} | \mathcal{X}_n) \le [1 + \{2\log(p^2K)\}^{-1}]\{2\log(p^2K)\}^{1/2} \max_{1 \le \ell \le p^2K} \widehat{\Xi}_{\ell}^{1/2},$$

where  $\widehat{\Xi}_1, \ldots, \widehat{\Xi}_{p^2K}$  are the elements in the diagonal of  $\widehat{\Xi}_n$ . On the other hand, it holds  $\operatorname{pr}\{|G|_{\infty} \ge E(|G|_{\infty} | \mathcal{X}_n) + u | \mathcal{X}_n\} \le \exp\{-u^2/(2\max_{1\le \ell\le p^2K}\widehat{\Xi}_\ell)\}$  for any u > 0. Let  $\Xi_1, \ldots, \Xi_{p^2K}$  be the elements in the main diagonal of  $\Xi_n$ . In addition, for any v > 0, let  $\mathcal{E}_0(v) = \{\max_{1\le \ell\le p^2K} |\widehat{\Xi}_\ell^{1/2}/\Xi_\ell^{1/2} - 1| \le v\}$ . Restricted on  $\mathcal{E}_0(v)$ , it holds that

$$\widehat{cv}_{\alpha} \le (1+v)([1+\{2\log(p^2K)\}^{-1}]\{2\log(p^2K)\}^{1/2} + \{2\log(1/\alpha)\}^{1/2}) \max_{1 \le \ell \le p^2K} \Xi_{\ell}^{1/2}.$$

Let  $(i_0, j_0, k_0) = \arg \max_{1 \le k \le K} \max_{1 \le i, j \le p} |\rho_{i,j}(k)|$ . Without loss of generality, we assume  $\rho_{i_0, j_0}(k_0) > 0$ . Then, restricted on  $\mathcal{E}_0(v)$ , it holds that

$$T_n \ge n^{1/2} \widehat{\rho}_{i_0, j_0}(k_0) \ge n^{1/2} \widehat{\sigma}_{j_0}^{-1} \widehat{\sigma}_{j_0}^{-1} \{ \widehat{\sigma}_{i_0, j_0}(k_0) - \sigma_{i_0, j_0}(k_0) \} + n^{1/2} \rho_{i_0, j_0}(k_0) (1+v)^{-2}$$

Choose u in such a way that  $(1+v)^2 [1 + \{\log(p^2 K)\}^{-1} + u] = 1 + \varepsilon_n$ , for  $\varepsilon_n > 0$  satisfying that  $\varepsilon_n \to 0$  and  $\varepsilon_n (\log p)^{1/2} \to \infty$ . Consequently,

$$n^{1/2}\rho_{i_0,j_0}(k_0) \ge (1+v)^2 [1 + \{\log(p^2 K)\}^{-1} + u]\lambda(p,\alpha) \max_{1 \le \ell \le p^2 K} \Xi_{\ell}^{1/2}$$

Following the same arguments of Lemma A2, we can choose suitable  $v \to 0$  such that  $pr\{\mathcal{E}_0(v)^c\} \to 0$ . Therefore,

$$\operatorname{pr}(T_n > \widehat{\operatorname{cv}}_{\alpha}) \ge \operatorname{pr}\left(n^{1/2}\widehat{\rho}_{i_0,j_0}(k_0) > [1 + \{\log(p^2K)\}^{-1}]\lambda(p,\alpha) \max_{1 \le \ell \le p^2K} \Xi_{\ell}^{1/2}\right) \\ \ge \operatorname{pr}\left[\frac{n^{1/2}\{\widehat{\sigma}_{i_0,j_0}(k_0) - \sigma_{i_0,j_0}(k_0)\}}{\widehat{\sigma}_{i_0}\widehat{\sigma}_{j_0}} > -u\lambda(p,\alpha) \max_{1 \le \ell \le p^2K} \Xi_{\ell}^{1/2}, \ \mathcal{E}_0(v) \text{ holds}\right] \\ \ge 1 - \operatorname{pr}\left[\frac{n^{1/2}\{\widehat{\sigma}_{i_0,j_0}(k_0) - \sigma_{i_0,j_0}(k_0)\}}{\widehat{\sigma}_{i_0}\widehat{\sigma}_{j_0}} \le -u\lambda(p,\alpha) \max_{1 \le \ell \le p^2K} \Xi_{\ell}^{1/2}\right] - \operatorname{pr}\{\mathcal{E}_0(v)^c\}.$$

Notice that  $u \sim \varepsilon_n$ . Thus  $u\lambda(p,\alpha) \max_{1 \le \ell \le p^2 K} \Xi_{\ell}^{1/2} \to \infty$ , which implies that  $\operatorname{pr}(T_n > \widehat{\operatorname{cv}}_{\alpha}) \to 1$ . This completes the proof of Theorem 2.

#### A.5 Proof of Theorem 3

Let  $\widehat{W}^*$ ,  $\widehat{\Sigma}^*(0)$ ,  $\widehat{J}_n^*$  and  $\widehat{\Xi}_n^*$  be, respectively, the analogues of  $\widehat{W}$ ,  $\widehat{\Sigma}(0)$ ,  $\widehat{J}_n$  and  $\widehat{\Xi}_n$  with  $\varepsilon_t$  replaced by  $\widehat{\varepsilon}_t$ . By Lemma 3.1 of Chernozhukov et al. (2013), we only need to show  $|\widehat{\Xi}_n^* - \widehat{\Xi}_n|_{\infty} = o_p(1)$ . Recall  $\widehat{\Xi}_n = (I_K \otimes \widehat{W}) \widehat{J}_n(I_K \otimes \widehat{W})$  and  $\widehat{\Xi}_n^* = (I_K \otimes \widehat{W}^*) \widehat{J}_n^*(I_K \otimes \widehat{W}^*)$ , it suffices to prove  $|\widehat{W}^* - \widehat{W}|_{\infty} = o_p(1)$  and  $|\widehat{J}_n^* - \widehat{J}_n|_{\infty} = o_p(1)$ . Since the proofs for those two assertions are similar, we only present the proof for  $|\widehat{W}^* - \widehat{W}|_{\infty} = o_p(1)$  below. As  $\widehat{W} = [\operatorname{diag}\{\widehat{\Sigma}(0)\}]^{-1/2} \otimes [\operatorname{diag}\{\widehat{\Sigma}(0)\}]^{-1/2}$  and  $\widehat{W}^* = [\operatorname{diag}\{\widehat{\Sigma}^*(0)\}]^{-1/2} \otimes [\operatorname{diag}\{\widehat{\Sigma}^*(0)\}]^{-1/2}$ , it suffices to show  $|\widehat{\Sigma}^*(0) - \widehat{\Sigma}(0)|_{\infty} = o_p(1)$ . Put  $\widehat{\varepsilon}_t = (\widehat{\varepsilon}_{1,t}, \dots, \widehat{\varepsilon}_{p,t})^{\mathrm{T}}$  and  $\varepsilon_t = (\varepsilon_{1,t}, \dots, \varepsilon_{p,t})^{\mathrm{T}}$ . For any i, j, the (i, j)-th element of  $\widehat{\Sigma}^*(0) - \widehat{\Sigma}(0)$  is given by  $\Delta_{i,j} = n^{-1} \sum_{t=1}^n (\widehat{\varepsilon}_{i,t}\widehat{\varepsilon}_{j,t} - \varepsilon_{i,t}\varepsilon_{j,t})$ . Notice that  $\widehat{\varepsilon}_{i,t} = y_{i,t} - g_i(u_t; \widehat{\theta})$  and  $\varepsilon_{i,t} = y_{i,t} - g_i(u_t; \theta_0)$ . It holds that

$$\Delta_{i,j} = \frac{1}{n} \sum_{t=1}^{n} \{g_i(u_t; \widehat{\theta}) - g_i(u_t; \theta_0)\} \{g_j(u_t; \widehat{\theta}) - g_j(u_t; \theta_0)\} - \frac{1}{n} \sum_{t=1}^{n} \{g_i(u_t; \widehat{\theta}) - g_i(u_t; \theta_0)\} \varepsilon_{j,t} - \frac{1}{n} \sum_{t=1}^{n} \varepsilon_{i,t} \{g_j(u_t; \widehat{\theta}) - g_j(u_t; \theta_0)\}.$$

It follows from Cauchy-Schwarz inequality that

$$\Delta_{i,j}^{2} \leq 3 \left[ \frac{1}{n} \sum_{t=1}^{n} \{g_{i}(u_{t}; \widehat{\theta}) - g_{i}(u_{t}; \theta_{0})\}^{2} \right] \left[ \frac{1}{n} \sum_{t=1}^{n} \{g_{j}(u_{t}; \widehat{\theta}) - g_{j}(u_{t}; \theta_{0})\}^{2} \right] + 3 \left[ \frac{1}{n} \sum_{t=1}^{n} \{g_{i}(u_{t}; \widehat{\theta}) - g_{i}(u_{t}; \theta_{0})\}^{2} \right] \left( \frac{1}{n} \sum_{t=1}^{n} \varepsilon_{j,t}^{2} \right) + 3 \left[ \frac{1}{n} \sum_{t=1}^{n} \{g_{j}(u_{t}; \widehat{\theta}) - g_{j}(u_{t}; \theta_{0})\}^{2} \right] \left( \frac{1}{n} \sum_{t=1}^{n} \varepsilon_{i,t}^{2} \right).$$
(16)

By Condition 5, it holds uniformly for any i = 1, ..., p that

$$\frac{1}{n}\sum_{t=1}^{n} \{g_i(u_t; \widehat{\theta}) - g_i(u_t; \theta_0)\}^2 \le |\widehat{\theta} - \theta_0|_*^2 \left\{ \frac{2}{n} \sum_{t=1}^{n} M_i^2(u_t) \right\} + \frac{2}{n} \sum_{t=1}^{n} R_i^2(u_t; \widehat{\theta}, \theta_0) = O_p(\zeta_n^2 \varphi_{1,n} + \varphi_{2,n}).$$

On the other hand, Lemma A2 implies that  $\sup_{1 \le i \le p} n^{-1} \sum_{t=1}^{n} \varepsilon_{i,t}^2 = O_p(1)$ . This together with (16) imply that  $\Delta_{ij}^2 = O_p(\zeta_n^2 \varphi_{1,n} + \varphi_{2,n})$  uniformly for any  $i, j = 1, \ldots, p$ . Thus  $|\widehat{\Sigma}^*(0) - \widehat{\Sigma}(0)|_{\infty} = O_p(\zeta_n \varphi_{1,n}^{1/2} + \varphi_{2,n}^{1/2}) = o_p(1)$ . This completes the proof of Theorem 3.

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